IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Katoh, T. et al.

Serial No.: 09/711,504

Group Art Unit: 2826

Filed: November 14, 2000

Examiner: Sefer, A.

For:

THIN FILM TRANSISTOR AND FABRICATION METHOD OF THE SAME

Honorable Assistant Commissioner of Patents Washington, D.C. 20231

EXCESS CLAIM FEE PAYMENT LETTER

Sir:

Transmitted herewith is an amendment in the above-identified application. The fee has been calculated and is transmitted as shown below.

	AFTER AMENDMENT	PREV. PAID FOR	EXTRA CLAIMS PRESENT	<u>RATE</u>	FEE DUE	
Total Claims Indep. Claims	18 - 6 -	20 3	= 0 = 3	x \$18.00 x \$84.00	\$ \$	00.00 252.00
TOTAL ADDITIONAL FEE FOR THIS AMENDMENT						252.00

A check in the amount of \$252.00 is herewith enclosed to cover the excess claim fees. A duplicate copy of this sheet is enclosed.

Respectfully Submitted,

Date:

Sean M. McGinn Reg. No. 34,386

McGinn & Gibb, PLLC 8321 Old Courthouse Rd. Suite 200 Vienna, VA 2218-3817 (703) 761-4100

Customer No. 21254

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of

Katoh, T. et al.

Serial No.: 09/711

Filed: November 14, 2000

Group Art Unit: 2826

Examiner: Sefer, A.

For: THIN FILM TRANSISTOR AND FABRICATION METHOD OF THE SAME

Honorable Commissioner of Patents Washington, D.C. 20231

AMENDMENT UNDER 37 C.F.R. §1.111

Sir:

In response to the Office Action dated February 7, 2002, please amend the aboveidentified application as follows:

IN THE CLAIMS:

Please cancel claims 8-12 without prejudice or disclaimer.

Please amend the claims as follows.

1. (Amended) A thin film transistor including:

a back channel electrode, wherein a voltage of a front channel positioned on the side of a gate wiring of said thin film transistor is made equal to a voltage of said back channel positioned on the side of a back channel electrode by short-circuiting said back channel electrode to a gate electrode through a contact-hole provided in a portion of a semiconductor layer forming said thin film transistor.

6

5. (Amended) A thin film transistor as claimed in claim 1, wherein a passivation film patterned to have a width equal to that of said back channel electrode and said semiconductor layer are provided between said back channel and a gate insulating film.

07/11/2002 AUSKAN1 00000071 09711504

02 FC:102

1

252.00 OP